TOSHIBA Power Module Silicon N Channel IGBT

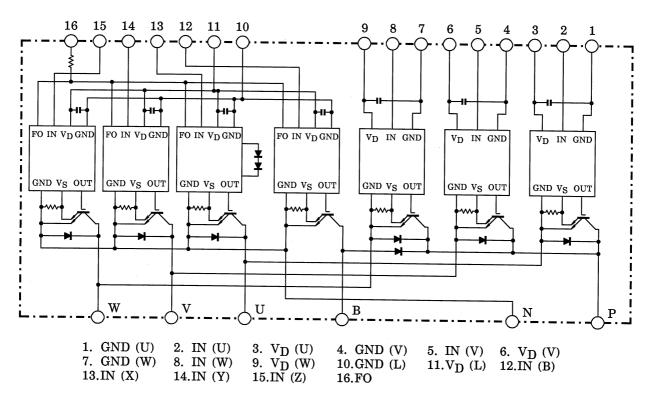
# MIG100J201HC

High Power Switching Applications

Motor Control Applications

- Integrates inverter, brake power circuits & control circuits (IGBT drive units, protection units for over-current, under-voltage & over-temperature) in one package.
- The electrodes are isolated from case.
- High speed type IGBT : V<sub>CE</sub> (sat) = 2.8 V (Max.)
  - $t_{off} = 3.0 \ \mu s$  (Max.)
  - $t_{rr} = 0.30 \ \mu s$  (Max.)
- Outline : TOSHIBA 2-110A1A
- Weight : 520 g

### **Equivalent Circuit**



# Maximum Ratings (T<sub>j</sub> = 25°C)

Stage	Characteristic	Condition	Symbol	Ratings	Unit
Inverter	Supply voltage	P-N power terminal	V <sub>CC</sub>	450	V
	Collector-emitter voltage	—	V <sub>CES</sub>	600	V
	Collector current	T <sub>c</sub> = 25°C, DC	Ι <sub>C</sub>	100	А
Inventer	Forward current	T <sub>c</sub> = 25°C, DC	١ <sub>F</sub>	100	А
	Collector power dissipation	T <sub>c</sub> = 25°C	P <sub>C</sub>	300	W
	Junction temperature	—	Tj	150	°C
Brake	Supply voltage	P-N power terminal	V <sub>CC</sub>	450	V
	Collector-emitter voltage	—	V <sub>CES</sub>	600	V
	Collector current	T <sub>c</sub> = 25°C, DC	Ι <sub>C</sub>	30	А
	Reverse voltage	—	V <sub>R</sub>	600	V
	Forward current	T <sub>c</sub> = 25°C, DC	lF	30	А
	Collector power dissipation	T <sub>c</sub> = 25°C	P <sub>C</sub>	80	W
	Junction temperature	—	Tj	150	°C
Control	Control supply voltage	V <sub>D</sub> -GND terminal	VD	20	V
	Input voltage	IN-GND terminal	V <sub>IN</sub>	20	V
	Fault output voltage	FO-GND (L) terminal	V <sub>FO</sub>	20	V
	Fault output current	FO sink current	I <sub>FO</sub>	14	mA
Module	Operating temperature	_	TC	-20 ~ +100	°C
	Storage temperature range	_	T <sub>stg</sub>	-40 ~ +125	°C
	Isolation voltage	AC 1 minute	V <sub>ISO</sub>	2500	V
	Screw torque	M5	—	3	N∙m

# Electrical Characteristics ( $T_j = 25^{\circ}C$ )

## a. Inverter Stage

Characteristic	Symbol	Test Condition		Min	Тур.	Max	Unit
Collector cut-off current	ICEX	V <sub>CE</sub> = 600 V	T <sub>j</sub> = 25°C	—	_	1	mA
Collector cut-on current			T <sub>j</sub> = 125°C	_	_	20	
Collector-emitter saturation voltage	V <sub>CE (sat)</sub>	$\begin{array}{l} V_{D} = 15 \; V, \; I_{C} = 100 \; A \\ V_{IN} = 15 \; V \rightarrow 0 \; V \end{array}$	T <sub>j</sub> = 25°C	_	2.3	2.8	v
			T <sub>j</sub> = 125°C	-	2.3	_	
Forward voltage	V <sub>F</sub>	I <sub>F</sub> = 100 A		-	2.1	3.3	V
	t <sub>on</sub>	$V_{CC}$ = 300 V, I <sub>C</sub> = 100 A V <sub>D</sub> = 15 V, V <sub>IN</sub> = 15 V ↔ 0 V		_	1.0	2.0	
Switching time	t <sub>off</sub>			_	1.7	3.0	
Switching time	t <sub>f</sub>	Inductive load (N	(Note 1)	_	0.2	0.5	μs
	t <sub>rr</sub>		(Note 1)	_	0.1	0.3	

# b. Brake Stage

Characteristic	Symbol	Test Condition		Min	Тур.	Max	Unit
Cellector cut-off current	ICEX	V <sub>CEX</sub> = 600V	T <sub>j</sub> = 25°C	_	_	1	mA
			T <sub>j</sub> = 125°C		_	20	
Collector-emitter saturation voltage	V <sub>CE (sat)</sub>	V <sub>D</sub> = 15V, I <sub>C</sub> = 30A V <sub>IN</sub> = 15V→0V	T <sub>j</sub> = 25°C	_	1.7	2.7	v
			T <sub>j</sub> = 125°C	_	1.6	_	
Reverse current	I <sub>R</sub>	V <sub>R</sub> =600V	T <sub>j</sub> = 25°C	_	—	1	mA
			T <sub>j</sub> = 125°C		_	20	
Forward voltage	V <sub>F</sub>	I <sub>F</sub> = 30A			2.0	2.5	V
	t <sub>on</sub>	$V_{CC} = 300V, I_C = 30A$ $V_D = 15V, V_{IN} = 15V \leftrightarrow 0V$ Inductive load			0.9	2.0	
Switching time	t <sub>off</sub>				1.7	3.0	
Switching time	t <sub>f</sub>			_	0.25	0.5	μs
	t <sub>rr</sub>		(Note 1)	_	0.15	0.3	

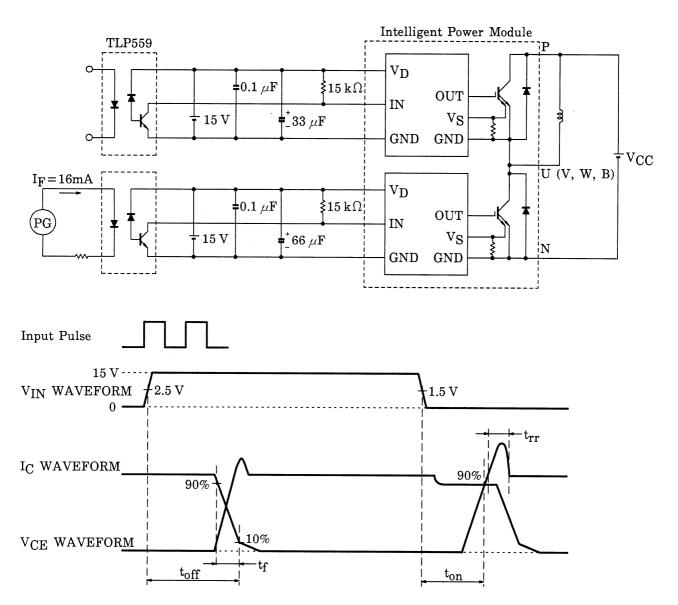
# c. Control Stage (T<sub>j</sub> = 25°C)

Characteristic		Symbol	Test Condition	Min	Тур.	Max	Unit
Control circuit current	High side	I <sub>D (H)</sub>	- V <sub>D</sub> = 15 V	—	8	—	mA
	Low side	I <sub>D (L)</sub>		_	35	_	IIIA
Input-on signal voltage		V <sub>IN (on)</sub>	V <sub>D</sub> = 15 V, I <sub>C</sub> = 100 mA	1.3	1.5	1.7	V
Input-off signal voltage		V <sub>IN (off)</sub>	V <sub>D</sub> = 15 V, I <sub>C</sub> = 100 mA	2.2	2.5	2.8	V
Fault output current	Protection	I <sub>FO (on)</sub>	- V <sub>D</sub> = 15 V -	8	10	12	mA
	Normal	I <sub>FO (off)</sub>		_	_	1	
Over current protection trip level	Inverter	- oc	V <sub>D</sub> = 15 V, T <sub>j</sub> = 125°C	160	200	_	A
	Brake			40	_	_	
Short current	Trip level		V <sub>D</sub> = 15 V, T <sub>j</sub> = 125°C	240	300	_	А
protection trip level	Reset level	SC		60	_	_	А
Over current cut-off time		t <sub>off (OC)</sub>	V <sub>D</sub> = 15 V	_	5	_	μs
Over	Trip level	ОТ	- Case temperature	110	118	125	.0°
temperature protection	Reset level	OTr		_	80	_	
Control supply under voltage protection	Trip level	UV	11.0 12	12.0	12.5	v	
	Reset level	UVr	1 –	_	12.5	_	v
Fault output pulse width		t <sub>FO</sub>	V <sub>D</sub> = 15 V	1	2	3	ms

#### d. Thermal Resistance (T<sub>j</sub> = 25°C)

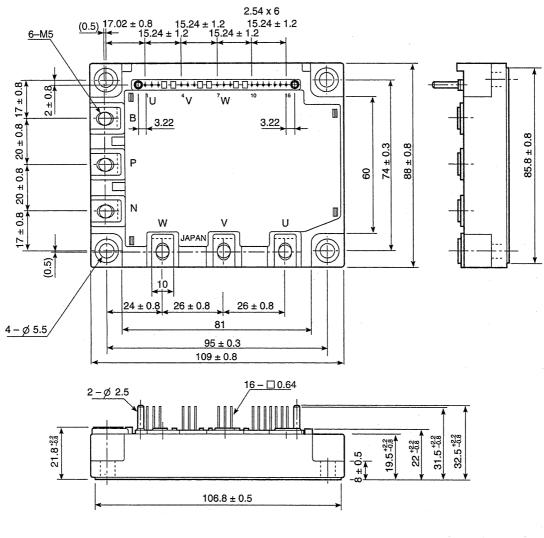
Characteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Junction to case thermal resistance		Inverter IGBT stage	_	_	0.418	°C / W
		Inverter FRD stage	-	-	1.000	
		Brake IGBTstage	-		1.562	
		Brake FRD stage	_	_	2.000	
Case to fin thermal resistance	R <sub>th (c-f)</sub>	Compound is applied	_	0.05	—	°C/W

Note 1: Switching time test circuit & timing chart



## Package Dimensions: TOSHIBA 2-110A1A

Unit: mm



GND IN VD GNDIN VD GND IN VD GND VD IN IN IN FO (U) (V) (W) (B) (X) (Y) (Z) 1 2 3 4 5 6 7 8 9 10 11 12 13 14 15 16 Signal Terminal 10 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0

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